

**Search Notes****Application/Control No.**

10/594,915

**Examiner**

Jinhee J. Lee

**Applicant(s)/Patent under  
Reexamination**

SHIMIZU, HAJIME

**Art Unit**

2175

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
plus search	2/29/2008	LEE